

WHAT IS CLAIMED IS:

1. An amorphous film having an aligned atomic structure disposed on a substrate prepared by a method comprising the step of:
5 bombarding said substrate with at least one ion beam from at least one ion beam source at a designated incident angle, wherein said ion beam has an energy from about 100 to 300 eV and said designated incident angle is from about 25 to about 60 degrees and wherein said amorphous film is a diamond-like carbon film, to simultaneously (a)
10 deposit said amorphous film onto said substrate, and (b) arrange said atomic structure of said amorphous film in at least one predetermined aligned direction.
2. The amorphous film of claim 1, wherein said designated
15 incident angle produces a net deposition on a surface of said substrate.
3. The amorphous film of claim 1, wherein said ion beam comprises impinging species and wherein the energy of said impinging species is kept below the energy required for etching said amorphous film
20 on a surface of said substrate.
4. The amorphous film of claim 1, wherein said ion beam is generated by a process comprising the steps of:
 introducing a carbon-containing gas into a discharge chamber of a
25 source of said ion beam;
 ionizing said carbon-containing gas in said discharge chamber to produce said ion beam comprising ions; and
 applying sufficient voltage to said ion beam to accelerate said ions out of said ion beam source.

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5. The amorphous film of claim 4, wherein said ion beam has an energy from about 200 to 300 eV.

6. The amorphous film of claim 1, wherein said ion beam is
5 generated using an ion gun.

7. The amorphous film of claim 1, wherein said ion beam further comprises neutral molecules.

8. The amorphous film of claim 1, wherein said bombarding is
10 carried out simultaneously using a first ion beam and a second ion beam.

9. The amorphous film of claim 8, wherein said designated
incident angle in said first ion beam is different from the designated
15 incident angle of said second ion beam.

10. The amorphous film of claim 1, wherein said designated
incident angle varies over time.

11. The amorphous film of claim 1, wherein said amorphous film
20 is optically transparent in the visible spectrum.

12. The amorphous film of claim 1, further comprising the step
of:
25 placing a collimator in the path of said ion beam between said
substrate and said ion beam source at a designated incident angle to
sputter material of said collimator onto said substrate.

13. The amorphous film of claim 1, further comprising the step
30 of:

moving said substrate or said ion beam source relative to the other over time.

14. An amorphous film having an aligned atomic structure
5 disposed on a substrate prepared by a method comprising the step of:
bombarding a collimator placed in the path of an ion beam from an
ion beam source between said substrate and said ion beam source at a
designated incident angle, wherein said ion beam has an energy from
about 100 to 300 eV and said designated incident angle is from about 25
10 to about 60 degrees and wherein said amorphous film is a diamond-like
carbon film, to sputter material of said collimator onto said substrate and
to simultaneously (a) deposit said amorphous film onto said substrate and
(b) arrange said atomic structure of said amorphous film in at least one
predetermined aligned direction.

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15. An amorphous film having an aligned atomic structure
disposed on a substrate prepared by a method comprising the steps of:
introducing a carbon-containing gas into a discharge chamber of an
ion beam source;
20 ionizing said carbon-containing gas in said discharge chamber to
produce an ion beam comprising ions;
applying sufficient voltage to said ion beam to accelerate said ions
out of said ion beam source; and
bombarding said substrate with at least one ion beam from at least
25 one ion beam source at a designated incident angle, wherein said ion
beam has an energy from about 100 to 300 eV and said designated
incident angle is from about 25 to about 60 degrees and wherein said
amorphous film is a diamond-like carbon film, to simultaneously (a)
deposit said amorphous film onto said substrate, and (b) arrange said
30 atomic structure of said amorphous film in at least one predetermined
aligned direction.

16. An apparatus for depositing an amorphous film having an aligned atomic structure on a substrate, comprising:

5 at least one ion beam source disposed at a designated incident angle of from about 25 to about 60 degrees capable of producing at least one ion beam having an energy from about 100 to 300 eV for bombarding said substrate with said ion beam to simultaneously (a) deposit said amorphous film onto said substrate, and (b) arrange said atomic structure of said amorphous film in at least one predetermined aligned direction.

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17. The apparatus of claim 16, wherein said amorphous film is optically transparent in the visible spectrum

18. The apparatus of claim 16, wherein said amorphous film is a
15 diamond-like carbon film.

19. The apparatus of claim 16, wherein said designated incident angle produces a net deposition on a surface of said substrate.

20 20. The apparatus of claim 16, wherein said ion beam comprises impinging species and wherein the energy of said impinging species is kept below the energy required for etching said amorphous film on a surface of said substrate.

25 21. The apparatus of claim 16, wherein said ion beam is generated by a process comprising the steps of:

introducing a carbon-containing gas into a discharge chamber of a source of said ion beam;

30 ionizing said carbon-containing gas in said discharge chamber to produce said ion beam comprising ions; and

applying sufficient voltage to said ion beam to accelerate said ions out of said ion beam source.

22. The apparatus of claim 16, wherein said ion beam has an
5 energy from about 200 to 300 eV.

23. The apparatus of claim 16, wherein said ion beam source is an ion gun.

10 24. The apparatus of claim 16, wherein said ion beam further comprises neutral molecules.

25. The apparatus of claim 16, further comprising:
means for moving said substrate relative to said ion beam source.

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26. The apparatus of claim 16, further comprising:
means for moving said ion beam source relative to said substrate.

27. The apparatus of claim 16, wherein said ion beam source
20 comprises a first ion beam source to produce a first ion beam and a second ion beam source to produce a second ion beam for bombarding simultaneously with said first and said second ion beams.

28. The apparatus of claim 27, further comprising:
25 means for moving at least one ion beam source relative to the others and relative to said substrate.

29. The apparatus of claim 27, further comprising:
means for varying said designated incident angle in said first or said
30 second ion beam such that said designated incident angle in said first or

said second ion beam is different from the designated incident angle of the other.

30. The apparatus of claim 27, further comprising:
5 means for varying said designated incident angle in said first or said second ion beam over time.

31. The apparatus of claim 27, further comprising:
means for moving said substrate or said ion beam source relative to
10 the other over time.

32. The apparatus of claim 16, further comprising:
a collimator in the path of said ion beam between said substrate
and said ion beam source at a designated incident angle for sputtering
15 material of said collimator onto said substrate.

33. The apparatus of claim 32, further comprising:
means for moving said substrate or said ion beam source relative to
the other and to said collimator over time.

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34. An apparatus for depositing an amorphous film having an
aligned atomic structure on a substrate, comprising:
at least one ion beam source disposed at a designated incident
angle of from about 25 to about 60 degrees capable of producing at least
25 one ion beam having an energy from about 100 to 300 eV; and
a collimator placed in the path of said ion beam produced from
said ion beam source between said substrate and said ion beam source at
a designated incident angle with said ion beam for bombarding said
collimator to sputter material of said collimator onto said substrate and
30 thereby simultaneously (a) deposit said amorphous film onto said

substrate and (b) arrange said atomic structure of said amorphous film in at least one predetermined aligned direction.

35. The apparatus of claim 34, wherein said ion beam is
5 produced by a method comprising the steps of:
introducing a carbon-containing gas into a discharge chamber of an
ion beam source;
ionizing said carbon-containing gas in said discharge chamber to
produce an ion beam comprising ions;
10 applying sufficient voltage to said ion beam to accelerate said ions
out of said ion beam source to produce at least one ion beam from said
ion beam source.

36. The apparatus of claim 34, wherein said amorphous film is
15 optically transparent in the visible spectrum

37. The apparatus of claim 34, wherein said amorphous film is a
diamond-like carbon film.

20 38. The apparatus of claim 35, wherein said designated incident
angle produces a net deposition on a surface of said substrate.